# SKiM 400GD126DM



SKiM<sup>®</sup> 4

### **IGBT** Modules

#### SKiM 400GD126DM

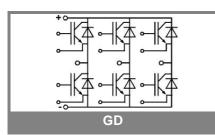
Target Data

#### Features

- Trench gate IGBT with field stop layer
- Low inductance case
- Fast & soft inverse CAL diodes
- Isolated by AIN DCB (Direct Copper Bonded) ceramic plate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- Integrated temperature sensor

### **Typical Applications\***

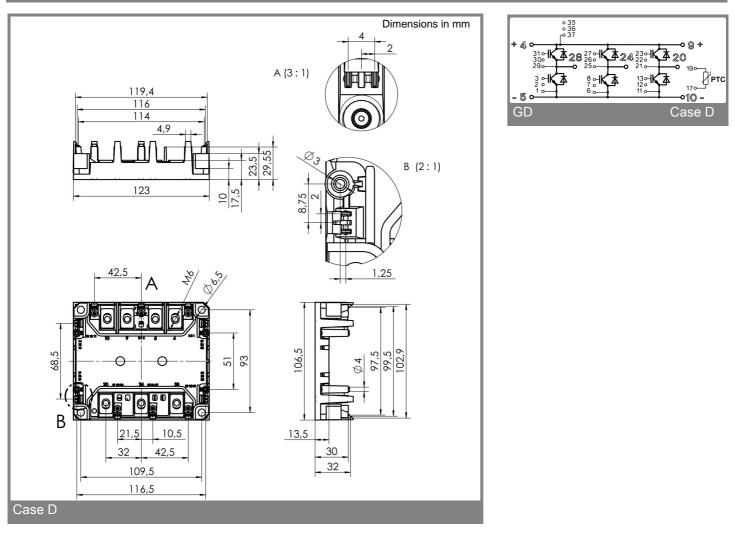
- Switched mode power supplies
- Three phase inverters for AC motor speed control
- Switching (not for linear use)



Absolute Maximum Ratings		$T_c = 25$ °C, unless otherwise specified							
Symbol	Conditions	Values	Units						
IGBT									
V <sub>CES</sub>		1200	V						
I <sub>C</sub>	T <sub>s</sub> = 25 (70) °C	330 (255)	Α						
I <sub>CRM</sub>	t <sub>p</sub> = 1 ms	600	Α						
V <sub>GES</sub>		± 20	V						
T <sub>i</sub> (T <sub>sta</sub> )		- 40 + 150 (125)	°C						
T <sub>cop</sub>	max. case operating temperature	125	°C						
V <sub>isol</sub>	AC, 1 min.	2500	V						
Inverse diode									
I <sub>F</sub>	T <sub>s</sub> = 25 (70) °C	300 (230)	А						
I <sub>FRM</sub>	$t_p = 1 \text{ ms}$	600	А						
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; sin.; T <sub>j</sub> = 150 °C	2200	А						

<b>Characteristics</b> $T_c = 25$ °C, unless otherwise spec					
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}$ ; I <sub>C</sub> = 12 mA	4,95	5,8	6,55	V
I <sub>CES</sub>	V <sub>GE</sub> = 0; V <sub>CE</sub> = V <sub>CES</sub> ; T <sub>i</sub> = 25 °C			0,6	mA
V <sub>CEO</sub>	T <sub>j</sub> = 25 (125) °C		1 (0,9)	1,2 (1,1)	V
r <sub>CE</sub>	T <sub>j</sub> = 25 (125) °C		2,3 (3,7)	3 (4,5)	mΩ
V <sub>CEsat</sub>	I <sub>Cnom</sub> = 300 A; V <sub>GE</sub> = 15 V,		1,7 (2)	2,15 (2,45)	V
	T <sub>j</sub> = 25 (125) °C on chip level				
C <sub>ies</sub>	V <sub>GE</sub> = 0; V <sub>CE</sub> = 25 V; f = 1 MHz		23		nF
C <sub>oes</sub>	V <sub>GE</sub> = 0; V <sub>CE</sub> = 25 V; f = 1 MHz		1,6		nF
C <sub>res</sub>	V <sub>GE</sub> = 0; V <sub>CE</sub> = 25 V; f = 1 MHz		1,6		nF
L <sub>CE</sub>				15	nH
R <sub>CC'+EE'</sub>	resistance, terminal-chip $T_c$ = 25 (125) °C		1,35 (1,75)		mΩ
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V				ns
t <sub>r</sub>	I <sub>Cnom</sub> = 300 A				ns
t <sub>d(off)</sub>	$R_{Gon} = R_{Goff} = \Omega$				ns
t <sub>f</sub>	T <sub>j</sub> = 125 °C				ns
$E_{on}\left(E_{off}\right)$	V <sub>GE</sub> ± 15 V		29 (46)		mJ
E <sub>on</sub> (E <sub>off</sub> )	with SKHI 64; T <sub>j</sub> = 125 °C				mJ
	V <sub>CC</sub> = 600 V; I <sub>C</sub> = 300 A				
Inverse d	liode				
$V_F = V_{EC}$	I <sub>Fnom</sub> = 200 A; V <sub>GE</sub> = 0 V; T <sub>i</sub> = 25 (125) °C		2 (1,8)	2,55 (2,3)	V
V <sub>TO</sub>	$T_i = 25 (125) °C$		1,1	1,45 (1,25)	V
r <sub>T</sub>	$T_{i}^{J} = 25 (125) ^{\circ}C$		4,5	5,3 (5,3)	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 300 A; T <sub>i</sub> = 125 °C				А
Q <sub>rr</sub>	$\dot{V}_{GE} = V di/dt = A/\mu s$				μC
E <sub>rr</sub>	R <sub>Gon</sub> = R <sub>Goff</sub> =				mJ
Thermal	characteristics				
R <sub>th(j-s)</sub>	per IGBT			0,134	K/W
R <sub>th(j-s)</sub>	per FWD			0,19	K/W
	ture Sensor				ı
R <sub>TS</sub>	T = 25 (100) °C		1 (1,67)		kΩ
tolerance	T = 25 (100) °C		3 (2)		%
Mechanic	al data				ı
M <sub>1</sub>	to heatsink (M5)	2		3	Nm
M <sub>2</sub>	for terminals (M6)	4		5	Nm
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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.